

Improved Algorithms for Largest Cardinality 2-Interval Pattern Problem

Hao Yuan, Linji Yang, and Erdong Chen

Department of Computer Science and Engineering
Shanghai Jiao Tong University
200030 Shanghai, P.R.China
{hyuan,ljyang,edchen}@cs.sjtu.edu.cn

Abstract. The 2-INTERVAL PATTERN problem is to find the largest constrained pattern in a set of 2-intervals. The constrained pattern is a subset of the given 2-intervals such that any pair of them are R -comparable, where model $R \subseteq \{<, \sqsubset, \emptyset\}$. The problem stems from the study of general representation of RNA secondary structures. In this paper, we give three improved algorithms for different models. Firstly, an $O(n \log n + \mathcal{L})$ algorithm is proposed for the case $R = \{\emptyset\}$, where $\mathcal{L} = O(dn) = O(n^2)$ is the total length of all 2-intervals (density d is the maximum number of 2-intervals over any point). This improves previous $O(n^2 \log n)$ algorithm. Secondly, we use dynamic programming technique to obtain an $O(n \log n + dn)$ algorithm for the case $R = \{<, \sqsubset\}$, which improves previous $O(n^2)$ result. Finally, we present another $O(n \log n + \mathcal{L})$ algorithm for the case $R = \{\sqsubset, \emptyset\}$ with disjoint support (interval ground set), which improves previous $O(n^2 \sqrt{n})$ upper bound.